| | Application No. | Applicant(s) |
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| | 10/523,223 Examiner | NAPPA ET AL. |
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| Jaf | Jafar Parsa | 1621 |
| The MAILING DATE of this communication apper All claims being allowable, PROSECUTION ON THE MERITS IS herewith (or previously mailed), a Notice of Allowance (PTOL-85) NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT RI of the Office or upon petition by the applicant. See 37 CFR 1.313 | (OR REMAINS) CLOSED in or other appropriate commining GHTS. This application is a | n this application. If not included unication will be mailed in due course. THIS |
| 1. This communication is responsive to application filed on 1/3 | <u>31/2005</u> . | |
| 2. The allowed claim(s) is/are <u>1-3</u> . | | · |
| 3. ☑ Acknowledgment is made of a claim for foreign priority un a) ☑ All b) ☐ Some* c) ☐ None of the: | | or (f). |
| 1. Certified copies of the priority documents have | | |
| 2. Certified copies of the priority documents have | | |
| Copies of the certified copies of the priority doc | cuments have been receive | d in this national stage application from the |
| International Bureau (PCT Rule 17.2(a)). | | |
| * Certified copies not received: | | |
| Applicant has THREE MONTHS FROM THE "MAILING DATE" of noted below. Failure to timely comply will result in ABANDONM THIS THREE-MONTH PERIOD IS NOT EXTENDABLE. | of this communication to file ENT of this application. | e a reply complying with the requirements |
| 4. A SUBSTITUTE OATH OR DECLARATION must be submi INFORMAL PATENT APPLICATION (PTO-152) which give | tted. Note the attached EXA | AMINER'S AMENDMENT or NOTICE OF reclaration is deficient. |
| 5. CORRECTED DRAWINGS (as "replacement sheets") must be submitted. | | |
| (a) I including changes required by the Notice of Draftsperso | on's Patent Drawing Reviev | w (PTO-948) attached |
| 1) ☐ hereto or 2) ☐ to Paper No./Mail Date | | |
| (b) ☐ including changes required by the attached Examiner's Paper No./Mail Date | Amendment / Comment or | r in the Office action of |
| Identifying indicia such as the application number (see 37 CFR 1, each sheet. Replacement sheet(s) should be labeled as such in the | 84(c)) should be written on t ne header according to 37 CF | he drawings in the front (not the back) of FR 1.121(d). |
| 6. DEPOSIT OF and/or INFORMATION about the deposit attached Examiner's comment regarding REQUIREMENT F | sit of BIOLOGICAL MATI FOR THE DEPOSIT OF BIO | ERIAL must be submitted. Note the DLOGICAL MATERIAL. |
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| Attachment(s) | | |
| 1. Notice of References Cited (PTO-892) | 5. Notice of In | formal Patent Application (PTO-152) |
| 2. Notice of Draftperson's Patent Drawing Review (PTO-948) | | ummary (PTO-413), |
| 3. A Information Disclosure Statements (PTO-1449 or PTO/SB/08 | Paper No./ 8), 7. ⊠ Examiner's | /Mail Date Amendment/Comment |
| Paper No./Mail Date <u>6/27/2005</u> 4. Examiner's Comment Regarding Requirement for Deposit of Biological Material | 8. 🛛 Examiner's | Statement of Reasons for Allowance |
| | 9. 🗌 Other | _• |
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EXAMINER'S AMENDMENT

An examiner's amendment to the record appears below.

IN THE CLAIM:

1. In claim 1, lines 1-2 "2-chloro-1,1,1,3,3,3-heptafluoropropane" has been corrected to -- 2-chloro-1,1,1,2,3,3,3-heptafluoropropane --.

Should the changes and/or additions be unacceptable to applicant, an amendment may be filed as provided by 37 CFR 1.312. To ensure consideration of such an amendment, it MUST be submitted no later than the payment of the issue fee.

Authorization for this examiner's amendment was given in a telephone interview with Mr. Heiser on 10/3/2005.

The following is an examiner's statement of reasons for allowance:

The prior art (WO99/51553 & EP 0434409) also teach a process for preparing 2-chloro-1,1,1,2,3,3,3-heptafluoropropane. The EP 0434409 reference discloses the use of a chromium oxide based catalyst containing copper, nickel and alkali metals. The WO 99/51553 discloses the use of trivalent chromium catalyst. The difference between the prior art and the claimed invention is that the claimed process requires at least one chromium-containing component selected from (i) a crystalline alpha-chromium oxide where at least 0.05 atom % of the chromium atoms in the alpha-chromium oxide lattice are replaced by nickel, trivalent cobalt or both nickel and trivalent cobalt, provided that no more than 2 atom % of the chromium atoms in the alpha-chromium oxide lattice are replaced by nickel and that the total amount of chromium atoms in the alpha-chromium

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oxide lattice that are replaced by nickel and trivalent cobalt is no more than 6 atom %, and (ii) a fluorinated crystalline oxide of (i).

Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Jafar Parsa whose telephone number is (571)272-0643. The examiner can normally be reached on 8 a.m.-4:30 p.m. (M-F).

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Johann Richter can be reached on (571)272-0646. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

Jafar Parsa Primary Examiner Art Unit 1624

J. PARSA PRIMARY EXAMINER

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